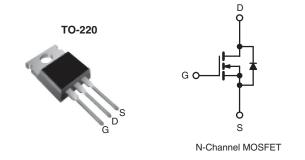
COMPLIANT





PRODUCT SUMMARY						
V <sub>DS</sub> (V)	60	60				
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.050				
Q <sub>g</sub> (Max.) (nC)	46	;				
Q <sub>gs</sub> (nC)	11	11				
Q <sub>gd</sub> (nC)	22	22				
Configuration	Sino	Single				



#### **FEATURES**

- · Dynamic dV/dt Rating
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- Lead (Pb)-free Available

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lood (Ph) from	IRFZ34PbF
Lead (Pb)-free	SiHFZ34-E3
SnPb	IRFZ34
JIIF D	SiHFZ34

ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, u	nless otherw	rise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	60	V	
Gate-Source Voltage			$V_{GS}$	± 20	1 '	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	30	A	
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		21		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	120		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	200	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		$P_D$	88	W	
Peak Diode Recovery dV/dt <sup>c</sup>	•		dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	- 00	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	- °C	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 259  $\mu$ H,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 30 A (see fig. 12). c.  $I_{SD} \le 30$  A,  $dI/dt \le 200$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.7		

<b>SPECIFICATIONS</b> $T_J = 25  ^{\circ}C$ ,	unless other	wise noted					
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static				•		•	
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.065	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$		$V_{GS}$ , $I_{D} = 250 \mu A$	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	25 250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 18 A <sup>b</sup>	-	-	0.050	Ω
Forward Transconductance	9fs	V <sub>DS</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 18 A		-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	1200	-	pF
Output Capacitance	C <sub>oss</sub>	1	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		600	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	100	-	
Total Gate Charge	Qg			-	-	46	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A, V <sub>DS</sub> = 48 V, see fig. 6 and 13 <sup>b</sup>	-	-	11	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	-	22	
Turn-On Delay Time	t <sub>d(on)</sub>			-	13	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, I_{D} = 30 \text{ A},$ $R_{G} = 12 \Omega, R_{D} = 1.0 \Omega, \text{ see fig. } 10^{b}$		-	100	-	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	29	-	
Fall Time	t <sub>f</sub>			-	52	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	
Drain-Source Body Diode Characteristic	cs	1					
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	30	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	120	Α
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 30 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 30 A, dI/dt = 100 A/μs		-	120	230	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.7	1.4	nC
		Intrinsic turn-on time is negligible (turn		nsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			

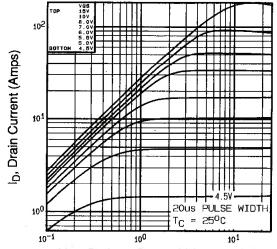
#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.

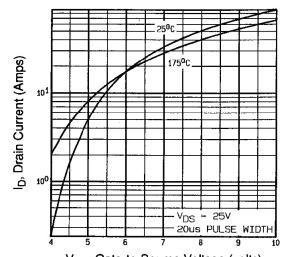




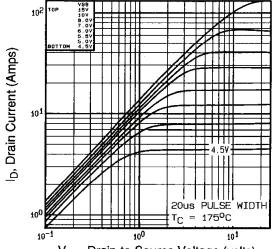
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



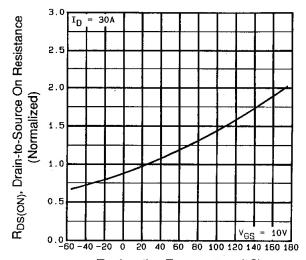
 $V_{DS}$ , Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics,  $T_C = 25 \,^{\circ}C$ 



V<sub>GS</sub>, Gate-to-Source Voltage (volts) Fig. 3 - Typical Transfer Characteristics



 $V_{DS}$ , Drain-to-Source Voltage (volts) Fig. 2 - Typical Output Characteristics,  $T_C$  = 175 °C



 $T_{J},$  Junction Temperature (°C) Fig. 4 - Normalized On-Resistance vs. Temperature



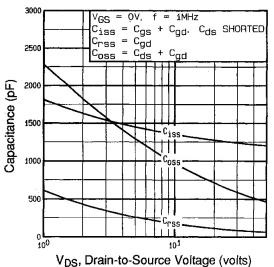


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

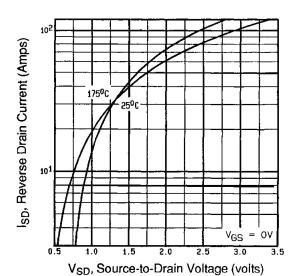
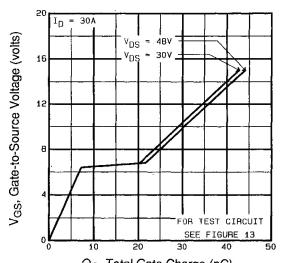


Fig. 7 - Typical Source-Drain Diode Forward Voltage



 $Q_G,\ Total\ Gate\ Charge\ (nC)$  Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

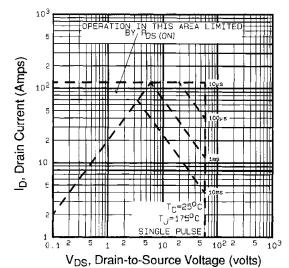
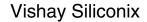


Fig. 8 - Maximum Safe Operating Area





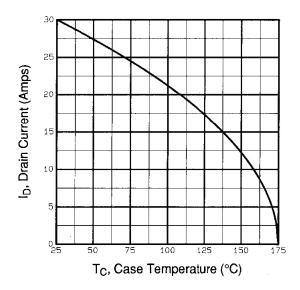


Fig. 9 - Maximum Drain Current vs. Case Temperature

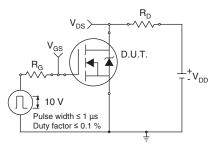


Fig. 10a - Switching Time Test Circuit

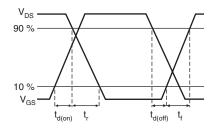


Fig. 10b - Switching Time Waveforms

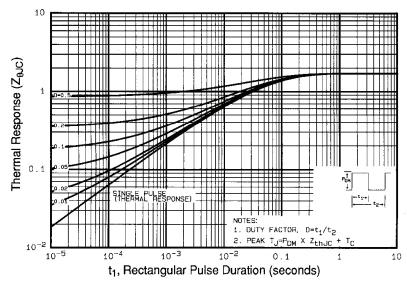


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

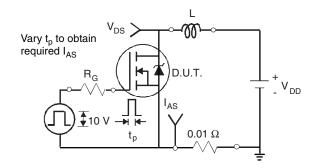


Fig. 12a - Unclamped Inductive Test Circuit

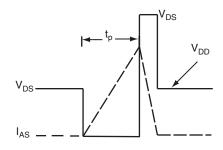


Fig. 12b - Unclamped Inductive Waveforms



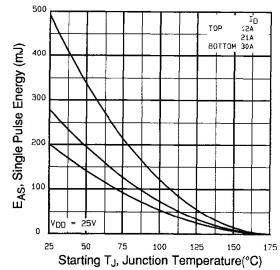


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

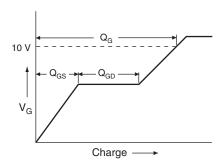


Fig. 13a - Basic Gate Charge Waveform

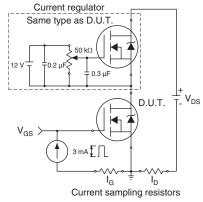
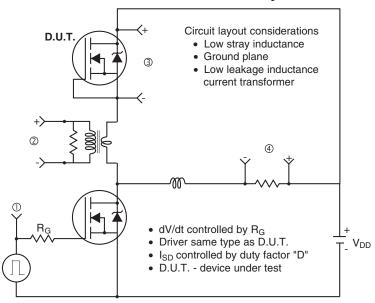
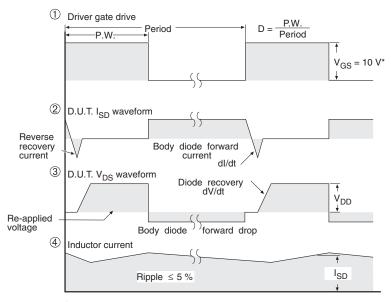


Fig. 13b - Gate Charge Test



### Peak Diode Recovery dV/dt Test Circuit





\* V<sub>GS</sub> = 5 V for logic level devices

Fig. 14 - For N-Channel

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